

Notice of References Cited	Application/Control No. 10/774,178		Applicant(s)/Patent Under Reexamination YEUNG ET AL.	
	Examiner CAROLINE ARCOS		Art Unit 2195	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,581,701 A	04-1986	Hess et al.	700/82
*	B	US-5,133,077 A	07-1992	Karne et al.	712/23
*	C	US-5,261,076 A	11-1993	Shamshirian, Massoud	712/200
*	D	US-5,450,546 A	09-1995	Krakirian, Chahe H.	710/57
*	E	US-5,579,452 A	11-1996	Ambalavanar et al.	358/1.16
*	F	US-5,640,604 A	06-1997	Hirano, Keizo	710/56
*	G	US-5,668,993 A	09-1997	Peters et al.	718/101
*	H	US-5,812,860 A	09-1998	Horden et al.	713/322
*	I	US-6,021,457 A	02-2000	Archer et al.	710/260
*	J	US-6,092,108 A	07-2000	DiPlacido et al.	709/224
*	K	US-6,199,160 B1	03-2001	Echensperger et al.	713/100
*	L	US-6,205,078 B1	03-2001	Merritt, Todd A.	365/226
*	M	US-2001/0043353 A1	11-2001	IIZUKA et al.	358/1.14

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/774,178		Applicant(s)/Patent Under Reexamination YEUNG ET AL.	
	Examiner CAROLINE ARCOS		Art Unit 2195	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0169990 A1	11-2002	Sherburne, Robert Warren JR.	713/300
*	B	US-6,493,741 B1	12-2002	Emer et al.	718/107
*	C	US-2002/0188884 A1	12-2002	Jain et al.	713/500
*	D	US-6,510,099 B1	01-2003	Wilcox et al.	365/230.06
*	E	US-6,577,602 B1	06-2003	Beck et al.	370/241.1
*	F	US-2003/0115428 A1	06-2003	Zaccarin et al.	711/156
*	G	US-6,601,112 B1	07-2003	O'Rourke et al.	719/312
*	H	US-6,662,203 B1	12-2003	Kling et al.	718/103
*	I	US-2004/0003019 A1	01-2004	Ali-Santosa et al.	709/100
*	J	US-2004/0030547 A1	02-2004	Leaning et al.	704/211
*	K	US-2004/0064573 A1	04-2004	Leaning et al.	709/231
*	L	US-2004/0083478 A1	04-2004	Chen et al.	718/107
*	M	US-2004/0215668 A1	10-2004	Sun, Mingqiu	707/201

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/774,178		Applicant(s)/Patent Under Reexamination YEUNG ET AL.	
	Examiner CAROLINE ARCOS		Art Unit 2195	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0198223 A1	10-2004	Loh et al.	455/041.1
*	B	US-6,839,762 B1	01-2005	Yu et al.	709/230
*	C	US-2005/0050135 A1	03-2005	Hallermeier, Josef	709/200
*	D	US-6,862,500 B2	03-2005	Tzamaloukas, Assimakis	701/1
*	E	US-7,006,511 B2	02-2006	Lanzafame et al.	370/412
*	F	US-7,043,608 B2	05-2006	Sun, Mingqiu	711/135
*	G	US-7,058,786 B1	06-2006	Oliveri, Richard	711/203
*	H	US-7,185,070 B2	02-2007	Paul et al.	709/220
*	I	US-7,188,198 B2	03-2007	Beukema et al.	710/52
*	J	US-7,222,068 B2	05-2007	Leaning et al.	704/201
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.